Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
	RADULESCU ET AL.
Examiner	Art Unit
Raymond Phan	2111

Raymond Phan

SEARCHED					
Class	Subclass	Date	Examiner		
710	300-317, 8-19, 58-61	2/11/2007	RP		
709	201-203	2/13/2007	RP		
709	310-317	2/14/2007	RP		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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